# NTBGS001N06C

## Product Preview **Power MOSFET** 60 V, 1.0 m $\Omega$ , 363 A, Single N-Channel, D<sup>2</sup>PAK7

### Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- Lowers Switching Noise/EMI
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

## **Typical Applications**

- Power Tools, Battery Operated Vacuums
- UAV/Drones, Material Handling
- BMS/Storage, Home Automation

## **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	60	V
Gate-to-Source Voltage	Э		V <sub>GS</sub>	±20	V
$\begin{array}{l} \text{Continuous Drain} \\ \text{Current } R_{\theta JC} \\ \text{(Note 2)} \end{array}$	Steady State	T <sub>C</sub> = 25°C	Ι <sub>D</sub>	363	A
Power Dissipation $R_{\theta JC}$ (Note 2)	Oldic		P <sub>D</sub>	250	W
Continuous Drain Current R <sub>θJA</sub> (Notes 1, 2)	Steady State	T <sub>A</sub> = 25°C	Ι <sub>D</sub>	44	A
Power Dissipation $R_{\theta JA}$ (Notes 1, 2)	State		P <sub>D</sub>	3.8	W
Pulsed Drain Current	T <sub>A</sub> = 25	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	TBD	А
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	–55 to + 175	°C
Source Current (Body Diode)			۱ <sub>S</sub>	TBD	А
Single Pulse Drain-to-Source Avalanche Energy ( $I_L = TBD A_{pk}, L = TBD mH$ )			E <sub>AS</sub>	TBD	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using a 1 in<sup>2</sup>, 1 oz. Cu pad.

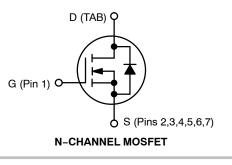
The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

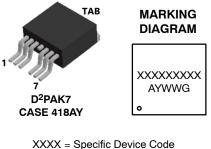


## **ON Semiconductor®**

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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
60 V	1.0 m $\Omega$ @ 10 V	363 A
00 V	TBD m $\Omega$ @ 6 V	000 A







## **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTBGS001N06C	D <sup>2</sup> PAK7 (Pb-Free)	800 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.

## NTBGS001N06C

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{ ext{ heta}JC}$	0.6	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{ ext{ heta}JA}$	40	

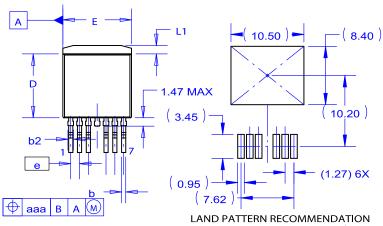
## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> = 250 $\mu$ A		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>	$I_D = 562 \ \mu$ A, ref to 25°C			TBD		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$ , $T_J = 25^{\circ}C$				10	μA
		V <sub>DS</sub> = 60 V	T <sub>J</sub> = 125°C			100	μA
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	= 20 V			100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> =	= 562 μA	2.0	3.0	4.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	I <sub>D</sub> = 562 μA, ref	to 25°C		TBD		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 112 A			TBD	1.0	
		V <sub>GS</sub> = 6 V, I <sub>D</sub>	= 56 A		TBD		mΩ
Forward Transconductance	<b>9</b> FS	V <sub>DS</sub> = 5 V, I <sub>D</sub> =	= 112 A		TBD		S
Gate-Resistance	R <sub>G</sub>	T <sub>A</sub> = 25°	С		1.0		Ω
CHARGES, CAPACITANCES & GATE RESIS	TANCE						
Input Capacitance	C <sub>ISS</sub>				9628		pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 30	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 30 V, f = 1 MHz		5719		
Reverse Transfer Capacitance	C <sub>RSS</sub>				53		
Total Gate Charge	Q <sub>G(TOT)</sub>				119		1
Threshold Gate Charge	Q <sub>G(TH)</sub>				TBD		1
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 30 V; $I_{D}$ = 112 A			41		nC
Gate-to-Drain Charge	Q <sub>GD</sub>				18		
Total Gate Charge	Q <sub>G(TOT)</sub>				TBD		
SWITCHING CHARACTERISTICS (Note 4)	<u> </u>				<u> </u>		
Turn-On Delay Time	t <sub>d(ON)</sub>				TBD		
Rise Time	tr	Vcc - 10 V Vcc	- 30 V		TBD		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 30 V, $I_{D}$ = 112 A, $R_{G}$ = 6 $\Omega$			TBD		ns
Fall Time	t <sub>f</sub>				TBD		
DRAIN-SOURCE DIODE CHARACTERISTIC	s						
Forward Diode Voltage	ward Diode Voltage V <sub>SD</sub>		T <sub>J</sub> = 25°C		TBD	1.2	
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 112 A	T <sub>J</sub> = 125°C		TBD		V
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dI <sub>S</sub> /dt = 100 A/µs, I <sub>S</sub> = 56 A			TBD		
Charge Time	ta				TBD		ns
Discharge Time	t <sub>b</sub>				TBD		
Reverse Recovery Charge	Q <sub>RR</sub>				TBD		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 3. Pulse Test: pulse width  $\leq$  300 µs, duty cycle  $\leq$  2%. 4. Switching characteristics are independent of operating junction temperatures.

## PACKAGE DIMENSIONS

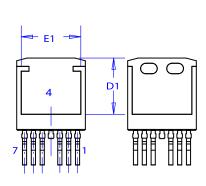
D<sup>2</sup>PAK7 (TO-263 7 LD) CASE 418AY **ISSUE B** 



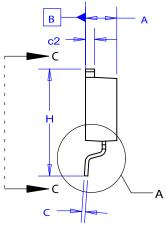
NOTES:

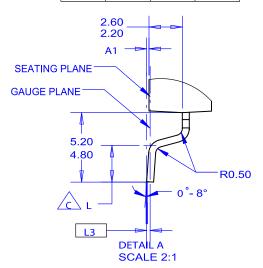
- A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.
- OUT OF JEDEC STANDARD VALUE.
  D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-1994.
  E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.
  F. LAND PATTERN RECOMMENDATION PER IPC. TO127P1524X465-8N.

	MILLIMETERS					
DIM	MIN	NOM	MAX			
А	4.30	4.50	4.70			
A1	0.00	0.10	0.20			
b2	0.70	0.80	0.90			
b	0.51	0.60	0.70			
С	0.40	0.50	0.60			
c2	1.20	1.30	1.40			
D	9.00	9.20	9.40			
D1	6.70	6.80	6.95			
Е	9.70	9.90	10.20			
E1	7.80	7.90	8.00			
е	~	1.27	1			
H	15.10	15.40	15.70			
L	2.44	2.64	2.84			
L1	1.00	1.20	1.40			
L3	~	0.25	~			
aaa	~	~	0.25			



**OPTIONAL CONSTRUCTIONS VIEW C-C** SCALE 2 : 1





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